Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10824434	YOON ET AL.	
Examiner	Art Unit	
Tan, Alvin H	2173	

SEARCHED						
Class	Subclass	Date	Examiner			
715	744, 747	5/3/07	AT			

SEARCH NOTES				
Search Notes	Date	Examiner		
715/744-747 (text search only - see search history printout)	5/3/07	AT		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	5/3/07	AT		
NPL - ACM Portal	·5/4/07	AT		

INTERFERENCE SEARCH					
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